

Notice of References Cited	Application/Control No. 10/560,951		Applicant(s)/Patent Under Reexamination NIWA ET AL.	
	Examiner RACHEL KAHN		Art Unit 4131	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06-345919	12-1994	Japan	Shibuya	
	O	JP 11-199741	07-1999	Japan	Yamamoto	
	P	JP 2002-172742	06-2002	Japan	Tanaka	
	Q	JP 2002-248721	09-2002	Japan	Matsui	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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